

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10617026	LEE ET AL.
	<b>Examiner</b> Moon, Seokyun	<b>Art Unit</b> 2629

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	94	11/21/2006	S.M.
	100	11/21/2006	S.M.

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (US-PGPUB, USPAT, JPO, EPO) Class 345 Combined with Text Search	11/21/2006	S.M.
EAST (US-PGPUB, USPAT, EPO, JPO) - See Search History Printout	11/21/2006	S.M.

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>